

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination	
			10/604,943	BENTWICH, ITZHAK	
Examiner			Art Unit		Page 1 of 1
Dana Shin			1635		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-	.		
	B	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 2005001128 A2	01-2005	World Intellect	MOYER et al.	
	O					
	P					
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**NON-PATENT DOCUMENTS**

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